

OptiMOS[™]3 Power-Transistor

Features

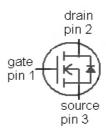
- Optimized technology for synchronous rectification
- Ideal for high frequency switching and DC/DC converters
- Excellent gate charge x R DS(on) product (FOM)
- Very low on-resistance R_{DS(on)}
- N-channel, normal level
- 100% avalanche tested
- Pb-free plating; RoHS compliant, halogen free
- Qualified according to JEDEC¹⁾ for target applications

Product Summa	m,

V _{DS}	75	٧
R _{DS(on),max}	2.3	mΩ
ID	120	Α



Туре	IPP023NE7N3 G	IPI023NE7N3 G
	123	123
Package	PG-TO220-3	PG-TO262-3
Marking	023NE7N	023NE7N



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C ²⁾	120	А
		T _C =100 °C	120	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	480	
Avalanche energy, single pulse ³⁾	E _{AS}	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω	1100	mJ
Gate source voltage	V_{GS}		±20	V
Power dissipation	P _{tot}	T _C =25 °C	300	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

¹⁾J-STD20 and JESD22

 $^{^{2)}}$ See figure 3 for more detailed information

³⁾ See figure 13 for more detailed information



IPP023NE7N3 G IPI023NE7N3 G

Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	0.5	K/W
Thermal resistance,	R_{thJA}	minimal footprint	-	-	62	
junction - ambient		6 cm ² cooling area ⁴⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	75	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	V _{DS} =V _{GS} , I _D =273 μA	2.3	3.1	3.8	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =75 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	0.1	1	μA
		V _{DS} =75 V, V _{GS} =0 V, T _j =125 °C	1	10	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =100 A	-	2.1	2.3	mΩ
Gate resistance	R _G		-	2.7	-	Ω
Transconductance	g fs	V _{DS} >2 I _D R _{DS(on)max} , I _D =100 A	98	195	-	s

 $^{^{4)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss		-	10800	14400	pF
Output capacitance	C _{oss}	V _{GS} =0 V, V _{DS} =37.5 V, f=1 MHz	-	2420	3220]
Reverse transfer capacitance	C _{rss}		-	110	-	
Turn-on delay time	t _{d(on)}		-	19	-	ns
Rise time	t _r	V _{DD} =37.5 V, V _{GS} =10 V, / _D =100 A,	-	26	-	
Turn-off delay time	$t_{\text{d(off)}}$	$R_{\rm G}$ =1.6 Ω	-	70	-	
Fall time	t _f		-	22	-	
Gate Charge Characteristics ⁵⁾		,				
Gate to source charge	Q _{gs}		-	54	-	nC
Gate to drain charge	Q _{gd}	V _{DD} =37.5 V,	-	31	-	╛
Switching charge	Q _{sw}	/ _D =100 A,	-	51	-	
Gate charge total	Qg	V _{GS} =0 to 10 V	-	155	206	
Gate plateau voltage	V _{plateau}		-	5.0	ı	٧
Output charge	Q oss	V _{DD} =37.5 V, V _{GS} =0 V	-	160	212	nC
Reverse Diode						
Diode continous forward current	Is	T _C =25 °C	-	-	120	А
Diode pulse current	/ _{S,pulse}	7 c-23 G	-	-	480	1
Diode forward voltage V_3		V _{GS} =0 V, I _F =100 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}	V _R =37.5 V, I _F =I _S ,	-	72	-	ns
Reverse recovery charge	Q_{rr} $di_F/dt = 100 \text{ A/}\mu\text{s}$		-	129	-	nC

⁵⁾ See figure 16 for gate charge parameter definition

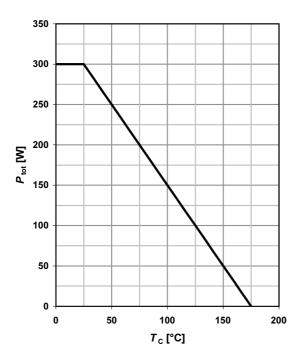


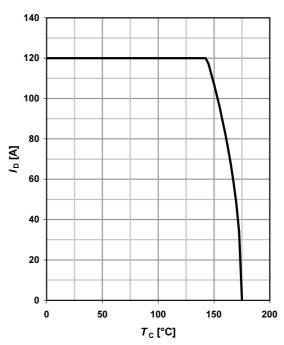
1 Power dissipation

P_{tot} =f(T_{C})

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$





3 Safe operating area

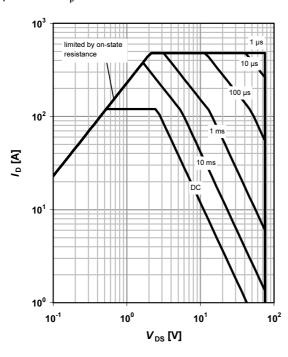
$$I_D$$
=f(V_{DS}); T_C =25 °C; D =0

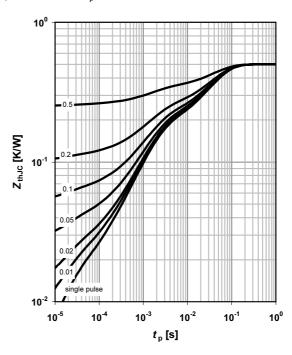
parameter: t_p

4 Max. transient thermal impedance

$$Z_{thJC}$$
=f(t_p)

parameter: $D = t_p/T$



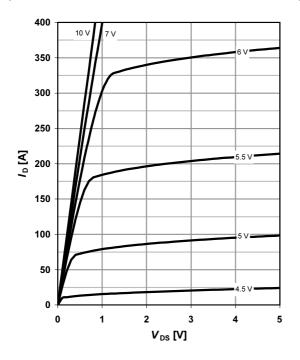




5 Typ. output characteristics

 I_D =f(V_{DS}); T_j =25 °C

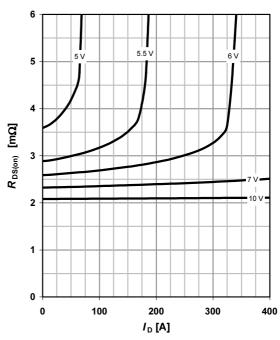
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

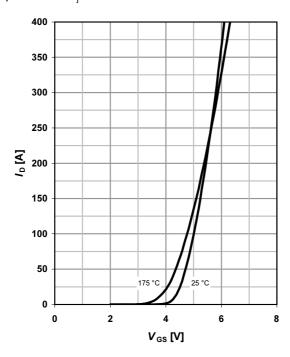
parameter: V_{GS}



7 Typ. transfer characteristics

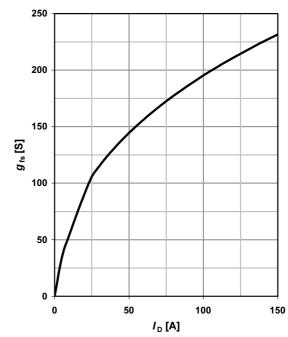
 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$

parameter: T_j



8 Typ. forward transconductance

 g_{fs} =f(I_D); T_j =25 °C





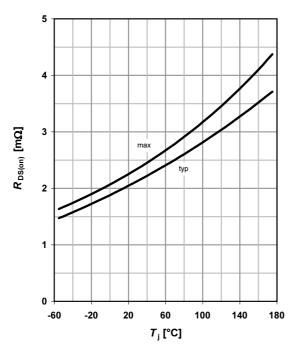
9 Drain-source on-state resistance

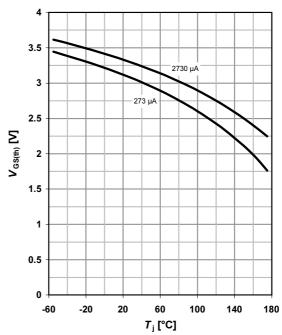
 $R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$

10 Typ. gate threshold voltage

 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D





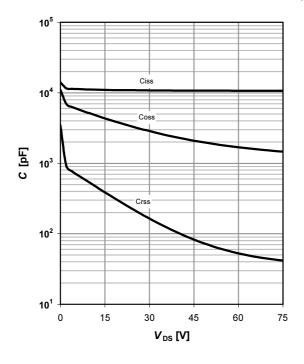
11 Typ. capacitances

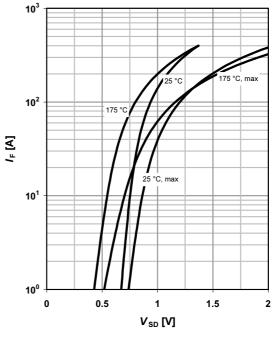
 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

parameter: T_j







13 Avalanche characteristics

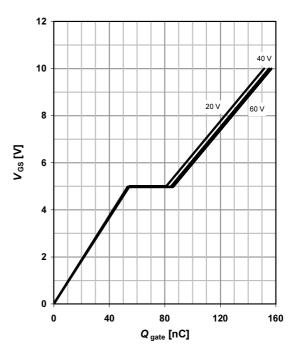
 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

parameter: $T_{j(start)}$

14 Typ. gate charge

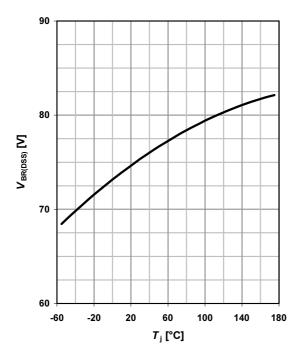
 $V_{\rm GS}$ =f(Q_{gate}); $I_{\rm D}$ =100 A pulsed

parameter: V_{DD}

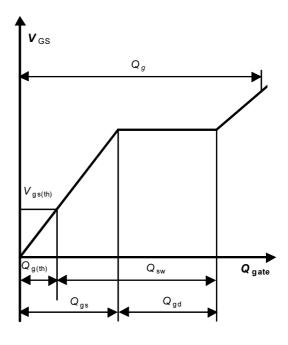


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_j); I_D =1 mA

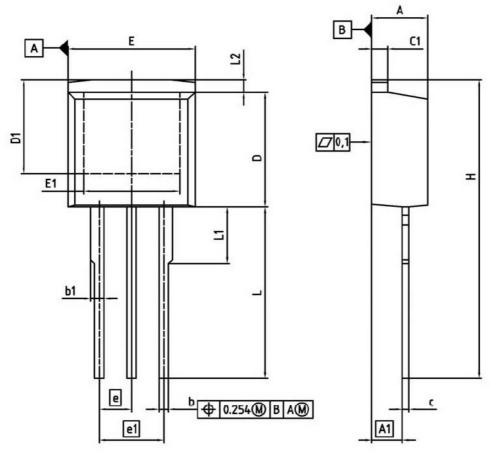


16 Gate charge waveforms





PG-TO262-3 (I²-Pak)

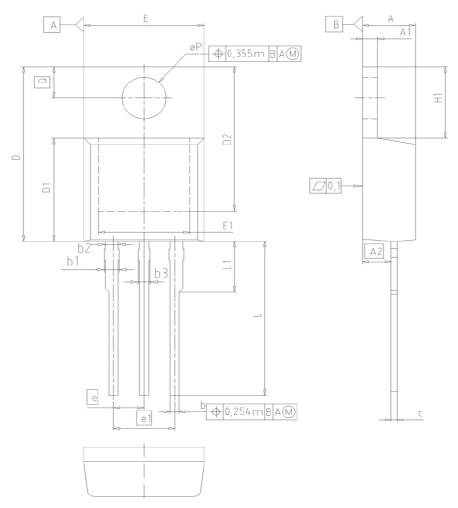


DIM	MILLIM	ETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.300	4.572	0.169	0.180
A1	2.150	2.718	0.085	0.107
b	0.650	0.864	0.026	0.034
b1	0.635	1.400	0.025	0.055
c	0.330	0.600	0.013	0.024
c1	1.170	1.400	0.046	0.055
D	8.509	9.450	0.335	0.372
D1	6.900		0.272	-
E	9.700	10.363	0.382	0.408
E1	6.500	8.600	0.256	0.339
e	2.5	40	0.1	100
el	5.080		0.2	200
N	3	3		3
L	13.000	14.000	0.512	0.551
L1		4.800		0.189
L2		1.727		0.068

	REFERENCE EDEC TO262
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1	SSUE DATE 05-05-2006
	FILE TO262_1



PG-TO220-3



DIM	MILLI	METERS	INCH	HES
DIN	MIN	MAX	MIN	MAX
Α	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
С	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
е	2.54		0.100	
e1	5	5.08 0.200		200
N		3	3	3
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
øΡ	3.60	3.89	0.142	0.153
0	2.60	3.00	0.102	0.118

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SCALE 0
2.5 0 2.5 5mm
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